SLOS082A - D2484, MARCH 1979 - REVISED JANUARY 1993

- Low Input Offset Voltage . . . 0.5 mV Max
- Low Power Consumption
- Wide Common-Mode and Differential Voltage Ranges
- Low Input Bias and Offset Currents
- High Input Impedance . . . JFET-Input Stage
- Internal Frequency Compensation
- Latch-Up-Free Operation
- High Slew Rate . . . 18 V/μs Typ
- Low Total Harmonic Distortion 0.003% Typ

description

These JFET-input operational amplifiers incorporate well-matched high-voltage JFET and bipolar transistors in a monolithic integrated circuit. They feature low input offset voltage, high slew rate, low input bias and offset currents, and low temperature coefficient of input offset voltage. Offset-voltage adjustment is provided for the TL087 and TL088.

The C-suffix devices are characterized for operation from 0° C to 70° C, and the I-suffix devices are characterized for operation from -40° C to 85° C. The M-suffix devices are characterized for operation over the full military temperature range of -55° C to 125° C.

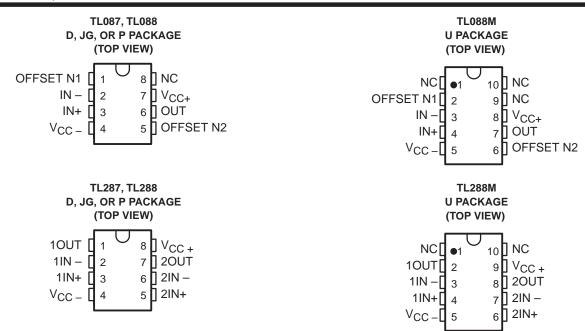
AVAILABLE OPTIONS

| | | Via may | | PACK | AGE | |
|-------------|--------|--------------------------------|----------------------|----------------------|--------------------|-------------|
| TA | TYPE | V _{IO} max AT 25°C | SMALL OUTLINE (D) | CERAMIC DIP (JG) | PLASTIC DIP (P) | FLAT (U) |
| 0°C to | Single | 0.5 mV 1 mV | TL087CD TL088CD | TL087CJG TL088CJG | TL087CP TL088CP | |
| 70°C | Dual | 0.5 mV 1 mV | TL287CD TL288CD | TL287CJG TL288CJG | TL287CP TL288CP | |
| -40°C to | Single | 0.5 mV 1 mV | TL087ID TL088ID | TL087IJG TL088IJG | TL087IP TL088IP | |
| 85°C | Dual | 0.5 mV 1 mV | TL287ID TL288ID | TL287IJG TL288IJG | TL287IP TL288IP | |
| −55°C to | Single | 1 mV | | TL088MJG | | TL088MU |
| 125°C | Dual | 1 mV | | TL288MJG | | TL288MU |

The D package is available taped and reeled. Add the suffix R to the device type (e.g., TL087CDR).

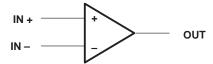


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NC - No internal connection

symbol (each amplifier)



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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

| | | TL088M TL288M | TL087I TL088I TL287I TL288I | TL087C TL088C TL287C TL288C | UNIT | | |
|--------------------------------------------------------------|----------------------------------|------------------------------|--------------------------------------|--------------------------------------|------|--|--|
| Supply voltage, VCC+ (see Note 1) | | 18 | 18 | 18 | V | | |
| Supply voltage, V _{CC} - (see Note 1) | | -18 | -18 | -18 | V | | |
| Differential input voltage (see Note 2) | | ±30 | ±30 | ±30 | V | | |
| Input voltage (see Notes 1 and 3) | | ±15 | ±15 | ±15 | V | | |
| Input current, I _I (each Input) | ±1 | ±1 | ±1 | mA | | | |
| Output current, IO (each output) | Output current, IO (each output) | | | | mA | | |
| Total V _{CC} + terminal current | | 160 | 160 | 160 | mA | | |
| Total V _{CC} - terminal current | | -160 | -160 | -160 | mA | | |
| Duration of output short circuit (see Note 4) | | unlimited unlimited unlimite | | | | | |
| Continuous total dissipation | | See Dissipation Rating Table | | | | | |
| Operating free-air temperature range | | -55 to 125 -25 to 85 | | 0 to 70 | °C | | |
| Storage temperature range | -65 to 150 -65 to 150 | | -65 to 150 | °C | | | |
| Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds | JG or U package | 300 | 300 | 300 | °C | | |
| Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds | D or P package | | 260 | 260 | °C | | |

- NOTES: 1. All voltage values, except differential voltages, are with respect to the midpoint between V_{CC+} and V_{CC-}.
 - 2. Differential voltages are at the noninverting input terminal with respect to the inverting input terminal.
 - 3. The magnitude of the input voltage must never exceed the magnitude of the supply voltage or 15 V, whichever is less.
 - 4. The output may be shorted to ground or to either supply. Temperature and/or supply voltages must be limited to ensure that the dissipation rating is not exceeded.

DISSIPATION RATING TABLE

| PACKAGE | $T_{\mbox{\scriptsize A}} \le 25^{\circ}\mbox{\scriptsize C}$ POWER RATING | DERATING FACTOR ABOVE T _{A =} 25°C | T _A = 70°C POWER RATING | T _A = 85°C POWER RATING | T _A = 125°C POWER RATING |
|---------|----------------------------------------------------------------------------|------------------------------------------------|---------------------------------------|---------------------------------------|----------------------------------------|
| D | 725 mW | 5.8 mW/°C | 464 mW | 377 mW | N/A |
| JG | 1050 mW | 8.4 mW/°C | 672 mW | 546 mW | 210 mW |
| Р | 1000 mW | 8.0 mW/°C | 640 mW | 520 mW | N/A |
| U | 675 mW | 5.4 mW/°C | 432 mW | 351 mW | 135 mW |

recommended operating conditions

| | | C-SUFFIX | | I-SUFFIX | | | M-SUFFIX | | | UNIT | |
|--------------------------------------------|--------------------------------|----------|-----|----------|-----|-----|----------|-----|-----|------|------|
| | | MIN | NOM | MAX | MIN | NOM | MAX | MIN | NOM | MAX | UNIT |
| Supply voltage, V _{CC} | | ±5 | | ±5 | ±5 | | ±5 | ±5 | | ±15 | V |
| Common mode input voltage Vie | $V_{CC\pm} = \pm 5 \text{ V}$ | -1 | | 4 | -1 | | 4 | -1 | | 4 | V |
| Common-mode input voltage, V _{IC} | $V_{CC\pm} = \pm 15 \text{ V}$ | -11 | | 11 | -11 | | 11 | -11 | | 11 | V |
| Input voltage V | $V_{CC\pm} = \pm 5 \text{ V}$ | -1 | | 4 | -1 | | 4 | -1 | | 4 | V |
| Input voltage, V _I | $V_{CC\pm} = \pm 15 \text{ V}$ | -11 | | 11 | -11 | | 11 | -11 | | 11 | V |
| Operating free-air temperature, Тд | | 0 | | 70 | -40 | | 85 | -55 | | 125 | °C |



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electrical characteristics, $V_{CC\pm} = \pm 15 \text{ V}$

| | PARAMETER | TEST C | onditions† | | ΓL088M ΓL288M | |] : | TL087I TL088I TL287I TL288I | | 1 | L087C L088C L287C L288C | | UNIT |
|------------------|-----------------------------------------------------------------------|---------------------------------------------------------------------------------------|--------------------------------------------------------------|-------|------------------|-----|---------------------|--------------------------------------|-----|----------------------|----------------------------------|-----|--------|
| | | | | MIN | TYP | MAX | MIN | TYP | MAX | MIN | TYP | MAX | |
| | | $R_S = 50 \Omega$, | TL087, TL287 | | | | | 0.1 | 0.5 | | 0.1 | 0.5 | |
| ., | land Marked a | $V_O = 0$ $T_A = 25^{\circ}C$ | TL088, TL288 | | 0.1 | 3 | | 0.1 | 1 | | 0.1 | 1 | |
| VIO | Input offset voltage | $R_S = 50 \Omega$, | TL087, TL287 | | | | | | 2 | | | 1.5 | mV |
| | | $V_O = 0$, $T_A = \text{full range}$ | TL088, TL288 | | | 6 | | | 3 | | | 2.5 | |
| α _{VIO} | Temperature coefficient of input offset voltage | $R_S = 50 \Omega$, | $T_A = 25$ °C to MAX | | 10 | | | 8 | | | 8 | | μV/°C |
| lia | Input offset current | T _A = 25°C | | | 5 | | | 5 | 100 | | 5 | 100 | рА |
| lio | Input offset current | T _A = full range | | | | 25 | | | 3 | | | 2 | nA |
| I _{IB} | Input bias current [‡] | T _A = 25°C | | | 30 | | | 30 | 200 | | 30 | 200 | рА |
| | | T _A = full range | | | | 100 | | | 20 | | | 7 | nA |
| VICR | Common-mode input voltage range | T _A = 25°C | | VCC-+ | :0 | | VCC-+ t VCC+- | 0 | | VCC-+ to VCC+- | | | V |
| | Marian made to made | T _A = 25°C, | $R_L = 10 \text{ k}\Omega$ | 24 | 27 | | 24 | 27 | | 24 | 27 | | |
| VO(PP) | Maximum-peak-to-peak output voltage swing | T _A = full range | $R_{L} \ge 10 \text{ k}\Omega$ $R_{L} \ge 2 \text{ k}\Omega$ | 24 | | | 24 20 | | | 24 20 | | | V |
| AVD | Large-signal differential | $R_L \ge 2 k\Omega$, $T_A = 25^{\circ}C$ | $V_0 = \pm 10 \text{ V},$ | 50 | 105 | | 50 | 105 | | 50 | 105 | | V/mV |
| , vD | voltage amplification | $R_L \ge 2 \text{ k}\Omega,$ $T_A = \text{full range}$ | $V_0 = \pm 10 \text{ V},$ | 25 | | | 25 | | | 25 | | | V/111V |
| B ₁ | Unity-gain bandwidth | T _A = 25°C | | | 3 | | | 3 | | | 3 | | MHz |
| rį | Input resistance | T _A = 25°C | | | 1012 | | | 1012 | | | 1012 | | Ω |
| CMRR | Common–mode rejection ratio | $R_S = 50 \Omega$, $V_{IC} = V_{ICR} min$ | | 80 | 93 | | 80 | 93 | | 80 | 93 | | dB |
| ksvr | Supply voltage rejection ratio (ΔV _{CC±} /ΔV _{IO}) | $R_S = 50 \Omega$, $V_{CC\pm} = \pm 9 V \text{ to}$ $T_A = 25^{\circ}\text{C}$ | | 80 | 99 | | 80 | 99 | | 80 | 99 | | dB |
| lcc | Supply current (per amplifier) | No load, T _A = 25°C | V _O = 0 V, | | 26 | 2.8 | | 2.6 | 2.8 | | 2.6 | 2.8 | mA |

[†] All characteristics are measured under open–loop conditions with zero common-mode input voltage unless otherwise specified. Full range for T_A is –55°C to 125°C for TL_88M; –40°C to 85°C for TL_8_I; and 0°C to 70°C for TL_8_C.
‡ Input bias currents of a FET-input operational amplifier are normal junction reverse currents, which are temperature sensitive. Pulse techniques must be used that will maintain

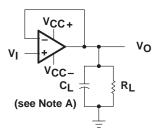


the junction temperature as close to the ambient temperature as possible.

operating characteristics $V_{CC}=\pm 15~V,\, T_A=25^{\circ}C$

| PARAMETER | | TEST C | TEST CONDITIONS | | | TL088M, TL288M | | | TL087I, TL087C TL088I, TL088C | | |
|----------------|--------------------------------|----------------------------------------------------|-------------------------------------|-----|-----|----------------|-----|-----|----------------------------------|--------------------|--|
| | | | | MIN | TYP | MAX | MIN | TYP | MAX | | |
| SR | Slew rate at unity gain | V _I = 10 V, C _L = 100 pF, | $R_L = 2 k\Omega$, $A_{VD} = 1$ | | 18 | | 8 | 18 | | V/μs | |
| t _r | Rise time | V _I = 20 mV, | R _L = 2 kΩ, | | 55 | | | 55 | | ns | |
| | Overshoot factor | $C_L = 100 pF$, | $A_{VD} = 1$ | | 25% | | | 25% | | | |
| ٧n | Equivalent input noise voltage | $R_S = 100 \Omega$, | f = 1 kHz | | 19 | | | 19 | | nV/√ Hz | |

PARAMETER MEASUREMENT INFORMATION



NOTE A: C_L includes fixture capacitance.

Figure 1. Slew Rate, Rise/Fall Time, and Overshoot Test Circuit

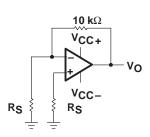


Figure 3. Noise Voltage Test Circuit

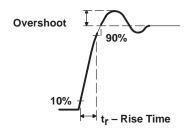
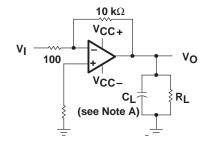


Figure 2. Rise Time and Overshoot Waveform



NOTE A: CL includes fixture capacitance.

Figure 4. Unity-Gain Brandwidth and Phase Margin Test Circuit

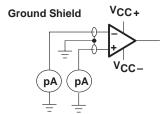


Figure 5. Input Bias and Offset Current Test Circuit

TL087, TL088, TL287, TL288 JFET-INPUT OPERATIONAL AMPLIFIERS

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typical values

Typical values as presented in this data sheet represent the median (50% point) of device parametric performance.

input bias and offset current

At the picoamp bias current level typical of these JFET operational amplifiers, accurate measurement of the bias current becomes difficult. Not only does this measurement require a picoammeter, but test socket leakages can easily exceed the actual device bias currents. To accurately measure these small currents, Texas Instruments uses a two-step process. The socket leakage is measured using picoammeters with bias voltages applied, but with no device in the socket. The device is then inserted in the socket and a second test that measures both the socket leakage and the device input bias current is performed. The two measurements are then subtracted algebraically to determine the bias current of the device.



TYPICAL CHARACTERISTICS

table of graphs

| | | | FIGURE |
|-----------------|-------------------------------------------------|---------------------------------------------------------------------------|------------------------------|
| αVIO | Temperature coefficient of input offset voltage | Distribution | 6, 7 |
| IIO | Input offset current | vs Temperature | 8 |
| IIB | Input bias current | vs V _{IC} vs Temperature | 9 8 |
| ٧I | Common-mode input voltage range limits | vs V _{CC} vs Temperature | 10 11 |
| VID | Differential input voltage | vs Output voltage | 12 |
| VOM | Maximum peak output voltage swing | vs V _{CC} vs Output current vs Frequency vs Temperature | 13 17 14, 15, 16 18 |
| A _{VD} | Differential voltage amplification | vs R _L vs Frequency vs Temperature | 19 20 21 |
| z _O | Output impedance | vs Frequency | 24 |
| CMRR | Common-mode rejection ratio | vs Frequency vs Temperature | 22 23 |
| ksvr | Supply-voltage rejection ratio | vs Temperature | 25 |
| los | Short-circuit output current | vs V _{CC} vs Time vs Temperature | 26 27 28 |
| lcc | Supply current | vs V _{CC} vs Temperature | 29 30 |
| SR | Slew rate | vs R _L vs Temperature | 31 32 |
| | Overshoot factor | vs C _L | 33 |
| Vn | Equivalent input noise voltage | vs Frequency | 34 |
| THD | Total harmonic distortion | vs Frequency | 35 |
| B ₁ | Unity-gain bandwidth | vs V _{CC} vs Temperature | 36 37 |
| фm | Phase margin | vs V _{CC} vs C _L vs Temperature | 38 39 40 |
| | Phase shift | vs Frequency | 20 |
| | Pulse response | Small-signal Large-signal | 41 42 |

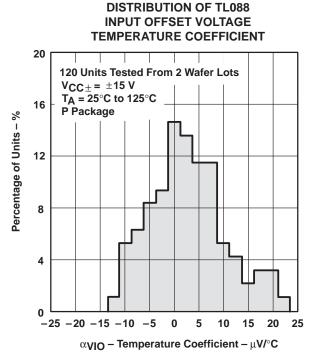
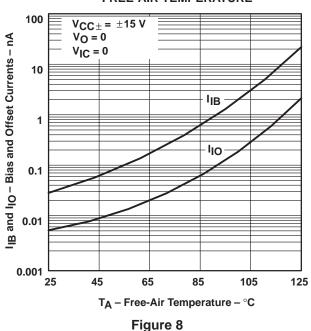


Figure 6

INPUT BIAS CURRENT AND INPUT OFFSET CURRENT vs FREE-AIR TEMPERATURE



DISTRIBUTION OF TL288 INPUT OFFSET VOLTAGE TEMPERATURE COEFFICIENT

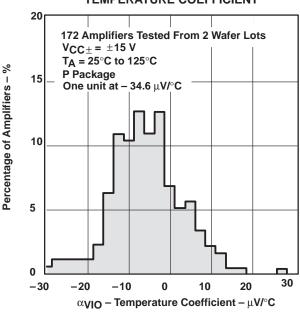
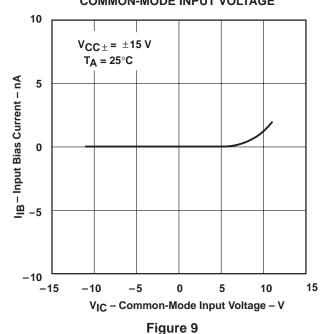


Figure 7

INPUT BIAS CURRENT vs COMMON-MODE INPUT VOLTAGE



† Data at high and low temperatures are applicable within the rated operating free-air temperature ranges of the various devices.



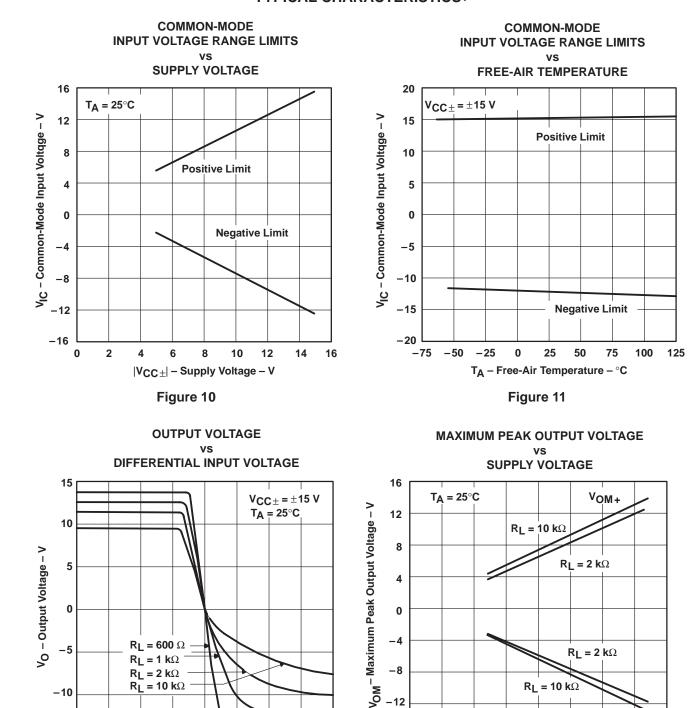


Figure 12 Figure 13

400

† Data at high and low temperatures are applicable within the rated operating free-air temperature ranges of the various devices.

 $R_L = 2 k\Omega$ $R_L = 10 \text{ k}\Omega$

0

V_{ID} - Differential Input Voltage - μV

200

-200

-10

-400



-8

12

-16

0

2

16

۷ом

10

 $|V_{CC\pm}|$ – Supply Voltage – V

MAXIMUM PEAK-TO-PEAK OUTPUT VOLTAGE FREQUENCY 30 VO(PP) - Maximum Peak-to-Peak Output Voltage - V $R_L = 2 k\Omega$ $V_{CC\pm} = \pm 15 \text{ V}$ 25 20 15 T_A = 125°C 10 $V_{CC\pm} = \pm 5 \text{ V}$ -55°C 5 10 k 100 k 1 M 10 M

Figure 14

f - Frequency - Hz

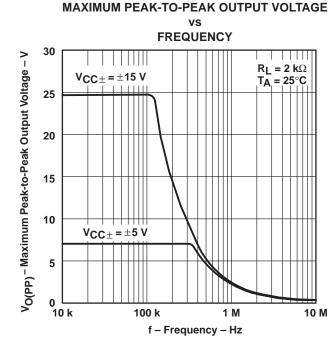
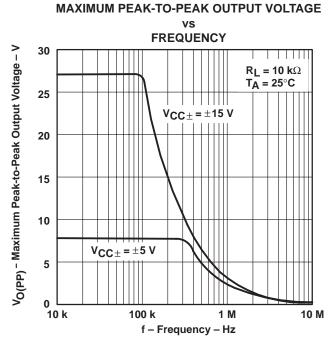
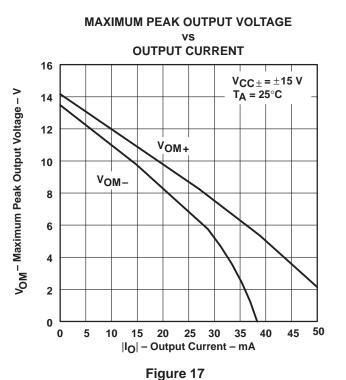


Figure 15







[†] Data at high and low temperatures are applicable within the rated operating free-air temperature ranges of the various devices.



MAXIMUM PEAK OUTPUT VOLTAGE FREE-AIR TEMPERATURE 16 $R_L = 10 k\Omega$ V_{OM} – Maximum Peak Output Voltage – V 12 VOM+ $R_L = 2 k\Omega$ 8 4 $V_{CC\pm} = \pm 15 V$ 0 -4 -8 VOM- $R_L = 2 k\Omega$ -12 $R_I = 10 k\Omega$ -16 75 -50-2525 50 100 125 T_A - Free-Air Temperature - °C

Figure 18

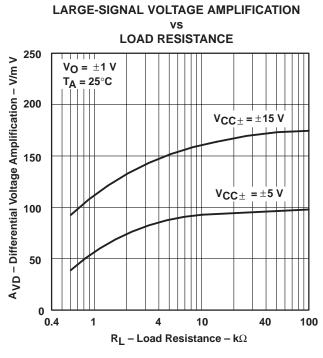


Figure 19

LARGE-SIGNAL DIFFERENTIAL VOLTAGE **AMPLIFICATION AND PHASE SHIFT**

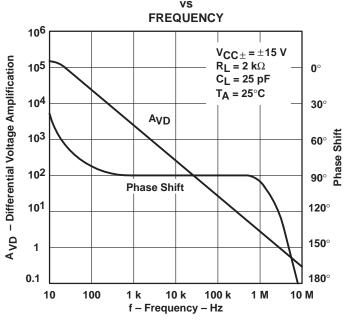


Figure 20

LARGE-SIGNAL VOLTAGE AMPLIFICATION

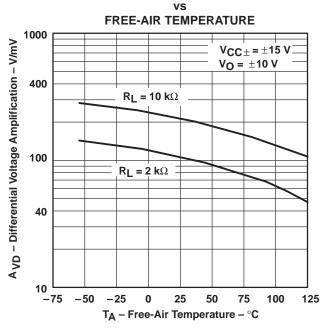


Figure 21

[†] Data at high and low temperatures are applicable within the rated operating free-air temperature ranges of the various devices.



COMMON-MODE REJECTION RATIO FREQUENCY 100 CMRR - Common-Mode Rejection Ratio - dB $V_{CC\pm} = \pm 15 \text{ V}$ 90 T_A = 25°C 80 70 60 50 40 30 20 10 100 10 k 100 k 1 M 10 M 10 f - Frequency - Hz

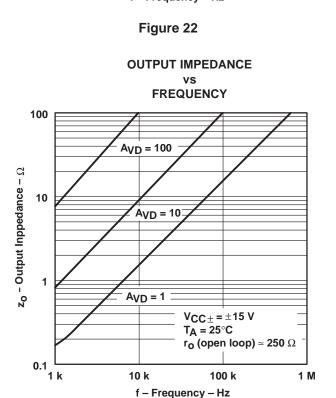


Figure 24

COMMON-MODE REJECTION RATIO FREE-AIR TEMPERATURE 100 CMRR - Common-Mode Rejection Ratio - dB VIC = VICR min 95 $V_{CC\pm} = \pm 15 V$ 90 85 $V_{CC\pm} = \pm 5 V$ 80 75 70 -50 25 50 75 100 125

Figure 23

 T_A – Free-Air Temperature – $^{\circ}$ C

SUPPLY-VOLTAGE REJECTION RATIO vs FREE-AIR TEMPERATURE

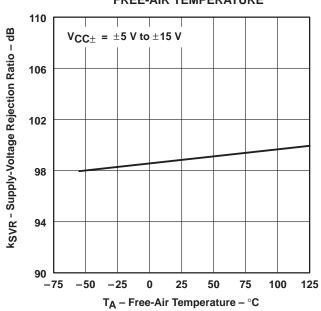


Figure 25

[†] Data at high and low temperatures are applicable within the rated operating free-air temperature ranges of the various devices.



SHORT-CIRCUIT OUTPUT CURRENT **SUPPLY VOLTAGE** 60 $V_O = 0$ Ios - Short-Circuit Output Current - mA $T_A = 25^{\circ}C$ 40 $V_{ID} = 1 V$ 20 0 -20 $V_{ID} = -1 V$ -60 2 10 12 14 16 $|V_{CC\pm}|$ – Supply Voltage – V

Figure 26

SHORT-CIRCUIT OUTPUT CURRENT

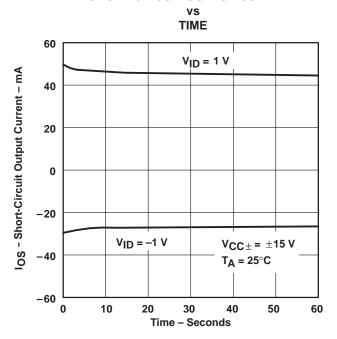


Figure 27

SHORT-CIRCUIT OUTPUT CURRENT

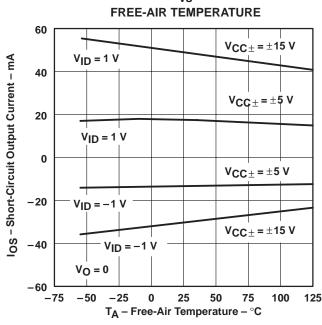
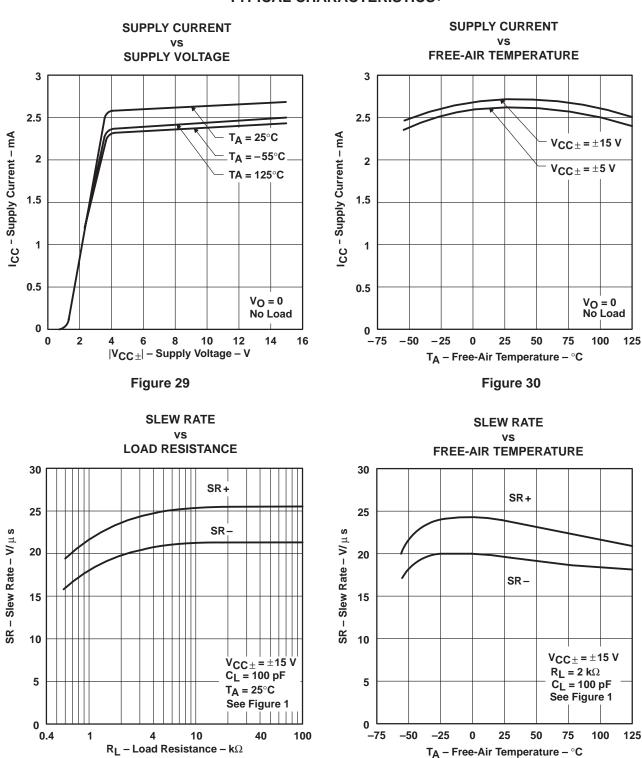


Figure 28

[†] Data at high and low temperatures are applicable within the rated operating free-air temperature ranges of the various devices.





[†] Data at high and low temperatures are applicable within the rated operating free-air temperature ranges of the various devices.

Figure 31



Figure 32

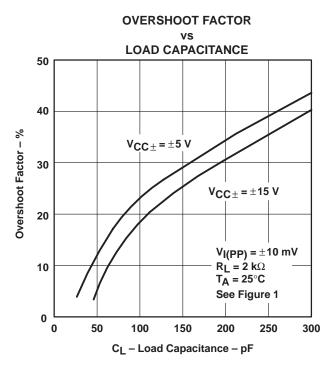


Figure 33

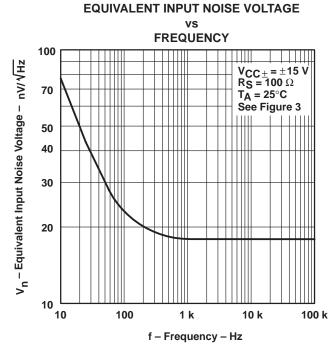
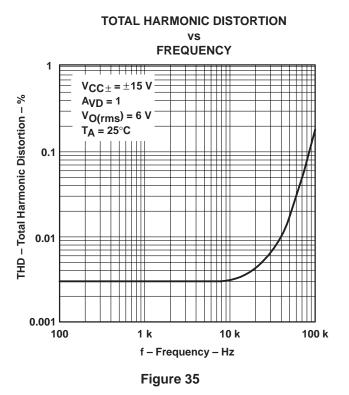
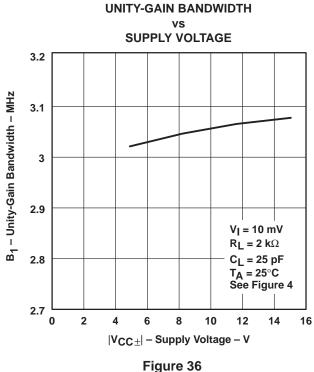


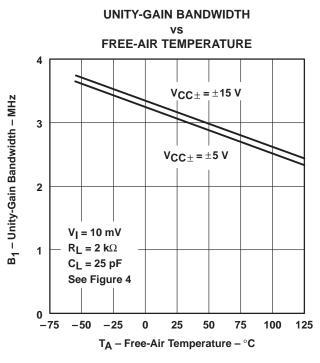
Figure 34





[†] Data at high and low temperatures are applicable within the rated operating free-air temperature ranges of the various devices.





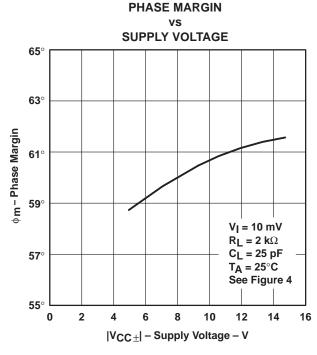
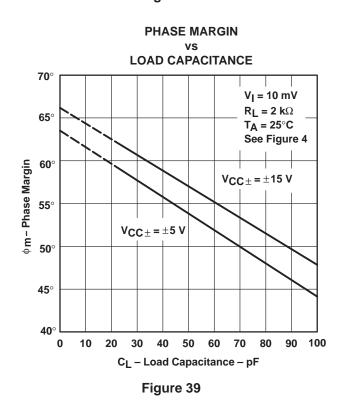
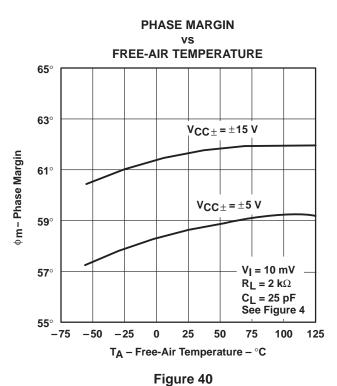


Figure 37



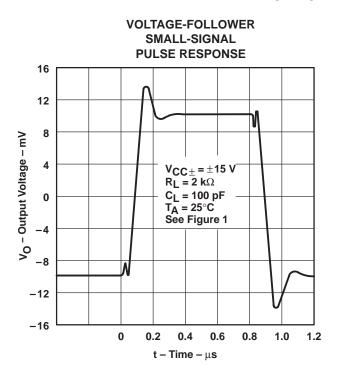




† Data at high and low temperatures are applicable within the rated operating free-air temperature ranges of the various devices.



TYPICAL CHARACTERISTICS



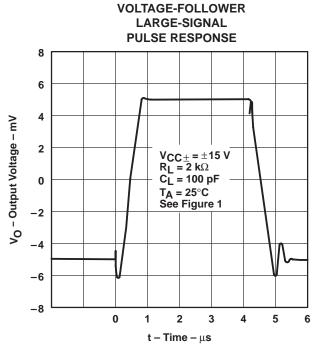


Figure 41

Figure 42

TYPICAL APPLICATION DATA

output characteristics

All operating characteristics are specified with 100-pF load capacitance. These amplifiers will drive higher capacitive loads; however, as the load capacitance increases, the resulting response pole occurs at lower frequencies, thereby causing ringing, peaking, or even oscillation. The value of the load capacitance at which oscillation occurs varies with production lots. If an application appears to be sensitive to oscillation due to load capacitance, adding a small resistance in series with the load should alleviate the problem. Capacitive loads of 1000 pF and larger may be driven if enough resistance is added in series with the output (see Figure 43).

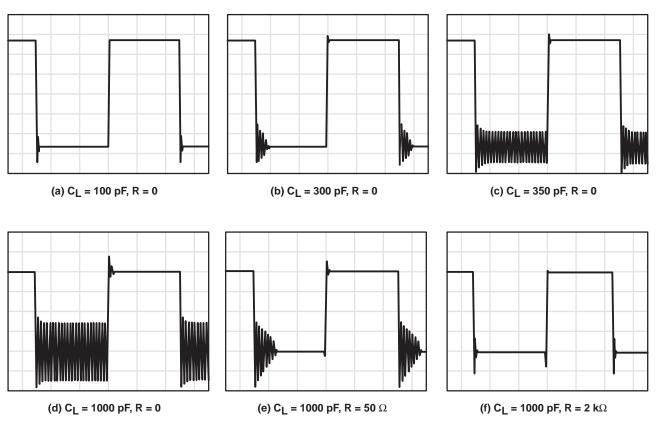


Figure 43. Effect of Capacitive Loads

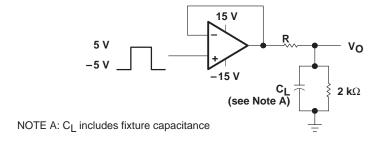


Figure 44. Test Circuit for Output Characteristics



TYPICAL APPLICATION DATA

input characteristics

These amplifiers are specified with a minimum and a maximum input voltage that, if exceeded at either input, could cause the device to malfunction.

Because of the extremely high input impedance and resulting low bias current requirements, these amplifiers are well suited for low-level signal processing; however, leakage currents on printed circuit boards and sockets can easily exceed bias current requirements and cause degradation in system performance. It is good practice to include guard rings around inputs (see Figure 45). These guards should be driven from a low-impedance source at the same voltage level as the common-mode input.

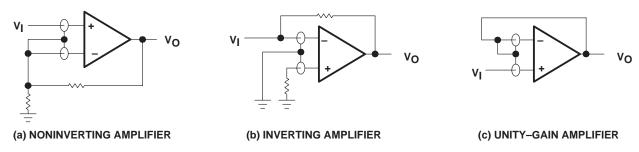


Figure 45. Use of Guard Rings

noise performance

The noise specifications in op amp circuits are greatly dependent on the current in the first-stage differential amplifier. The low input bias current requirments of these amplifiers result in a very low current noise. This feature makes the devices especially favorable over bipolar devices when using values of circuit impedance greater than 50 k Ω .

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